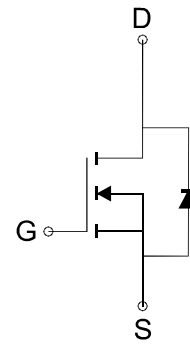
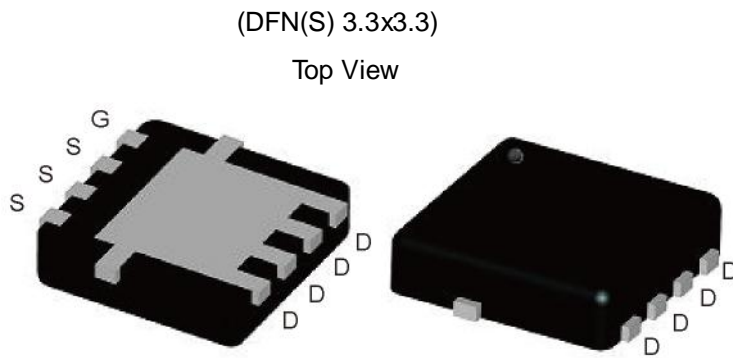


N-Channel 30V (D-S) MOSFET

GENERAL DESCRIPTION

The ME7804AS is the N-Channel logic enhancement mode power field effect transistors are produced using high cell density, DMOS trench technology. This high density process is especially tailored to minimize on-state resistance. These devices are particularly suited for low voltage application such as cellular phone and notebook computer power management and other battery powered circuits where high-side switching , and low in-line power loss are needed in a very small outline surface mount package.

PIN CONFIGURATION



N-Channel MOSFET

Ordering Information: ME7804AS-G (Green product-Halogen free)

Absolute Maximum Ratings (TA=25°C Unless Otherwise Noted)

Parameter		Symbol	Maximum Ratings	Unit
Drain-Source Voltage		V _{DS}	30	V
Gate-Source Voltage		V _{GS}	±20	V
Continuous Drain Current*	TA=25°C	I _D	11.5	A
	TA=70°C		9.2	
	Tc=25°C		26.9	
	Tc=100°C		17	
Pulsed Drain Current		I _{DM}	46	A
Maximum Power Dissipation*	TA=25°C	P _D	3.8	W
	TA=70°C		2.4	
	Tc=25°C		20.8	
	Tc=100°C		8.3	
Operating Junction Temperature		T _J	-55 to 150	°C
Thermal Resistance-Junction to Ambient*		RθJA	33	°C/W
Thermal Resistance-Junction to Case*		RθJC	6	°C/W

*The device mounted on 1in² FR4 board with 2 oz copper

FEATURES

- R_{DS(ON)} ≤18 mΩ@V_{GS}=10V
- R_{DS(ON)} ≤30 mΩ@V_{GS}=4.5V
- Super high density cell design for extremely low R_{DS(ON)}
- Exceptional on-resistance and maximum DC current capability

APPLICATIONS

- Power Management in Note book
- Portable Equipment
- Battery Powered System
- DC/DC Converter
- Load SwitchC
- LCD Display inverter

N-Channel 30V (D-S) MOSFET

Electrical Characteristics (TA=25°C Unless Otherwise Specified)

Symbol	Parameter	Limit	Min	Typ	Max	Unit
STATIC						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250 μA	30			V
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250 μA	1.0		3.0	V
I _{GSS}	Gate Leakage Current	V _{DS} =0V, V _{GS} =±20V			±100	nA
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =30V, V _{GS} =0V			1	μA
R _{DS(ON)}	Drain-Source On-State Resistance ^a	V _{GS} =10V, I _D =10A		14	18	mΩ
		V _{GS} =4.5V, I _D =5A		23	30	
g _{FS}	Forward Transconductance	V _{DS} =5V, I _D =8A		14		S
V _{SD}	Diode Forward Voltage	I _S =2.3A, V _{GS} =0V		0.76	1.1	V
DYNAMIC						
Q _g	Gate Charge	V _{DS} =15V, V _{GS} =10V, I _D =10A		15.5		nC
Q _{gt}	Total Gate Charge			7.8		
Q _{gs}	Gate-Source Charge	V _{DS} =15V, V _{GS} =4.5V, I _D =10A		3.2		
Q _{gd}	Gate-Drain Charge			3.8		
C _{iss}	Input capacitance	V _{DS} =15V, V _{GS} =0V, f=1MHz		535		pF
C _{oss}	Output Capacitance			95		
C _{rss}	Reverse Transfer Capacitance			30		
R _g	Gate Resistance	V _{DS} =0V, V _{GS} =0V, F=1MHz		0.9		Ω
t _{d(on)}	Turn-On Delay Time	V _{DD} =25V, R _L =25Ω I _D =1A, V _{GEN} =10V R _G =6Ω		12		ns
t _r	Turn-On Rise Time			9		
t _{d(off)}	Turn-Off Delay Time			39		
t _f	Turn-Off Fall Time			6		

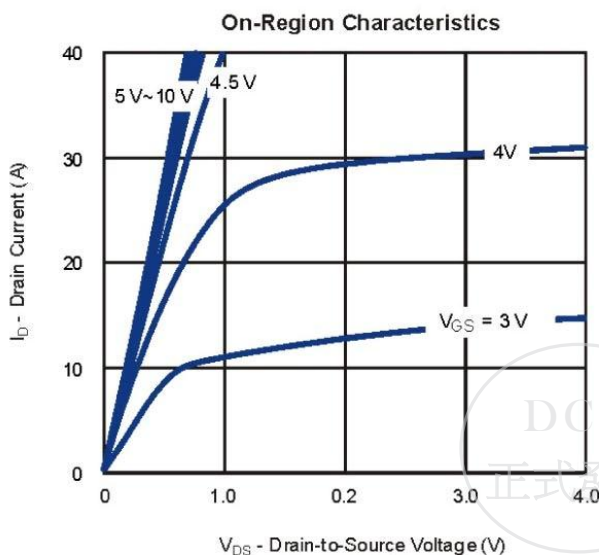
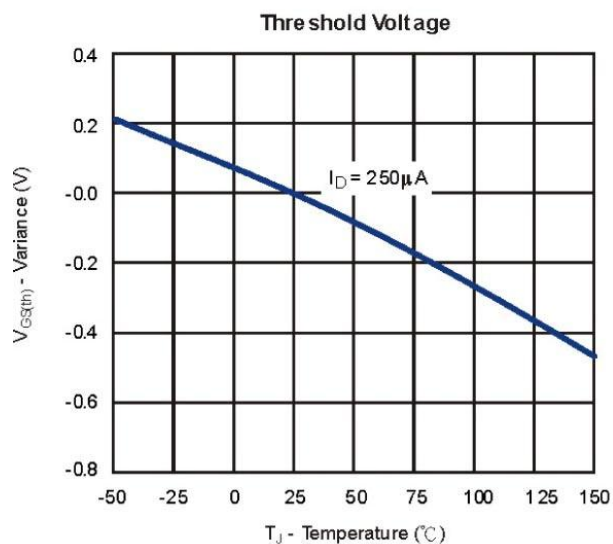
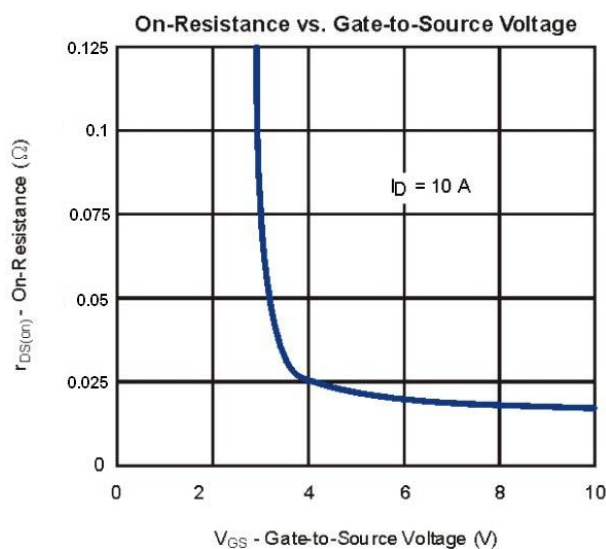
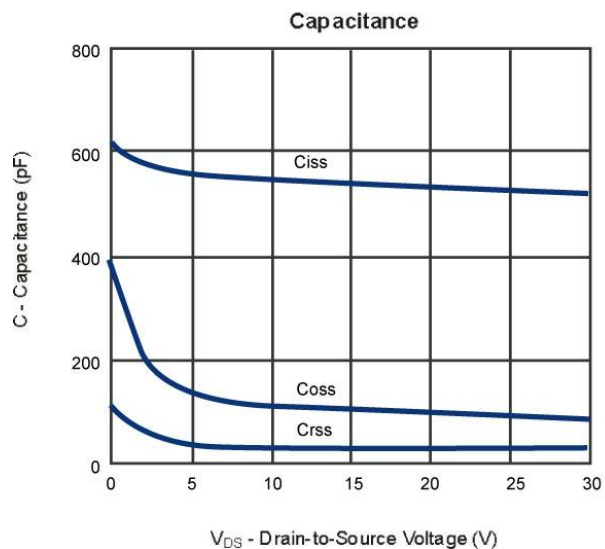
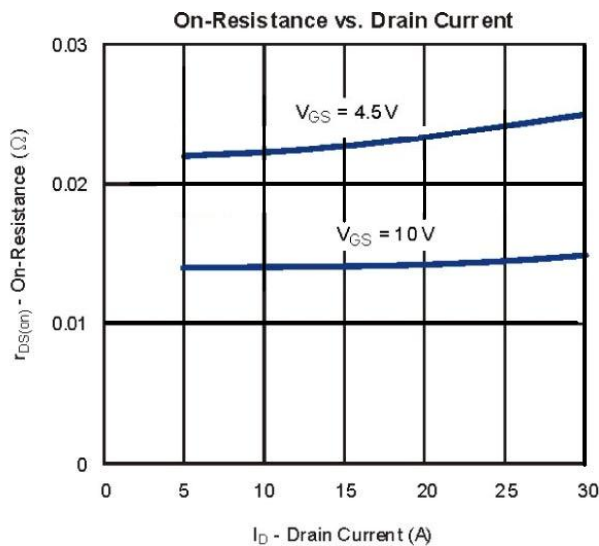
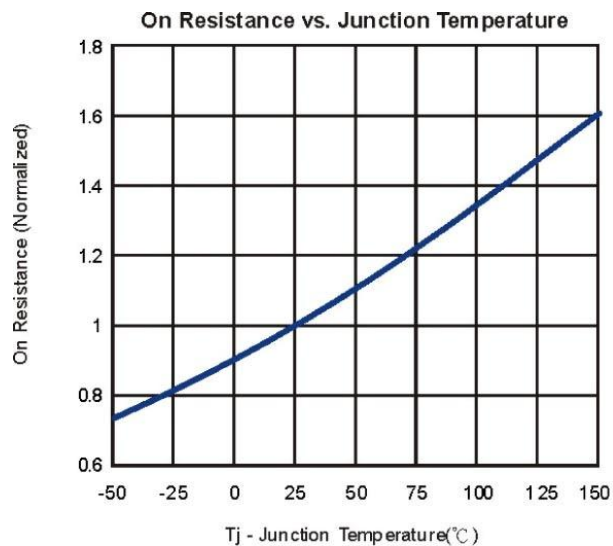
Notes: a. Pulse test: pulse width ≤ 300us, duty cycle ≤ 2%, Guaranteed by design, not subject to production testing.

b. Matsuki Electric/ Force mos reserves the right to improve product design, functions and reliability without notice.



N-Channel 30V (D-S) MOSFET

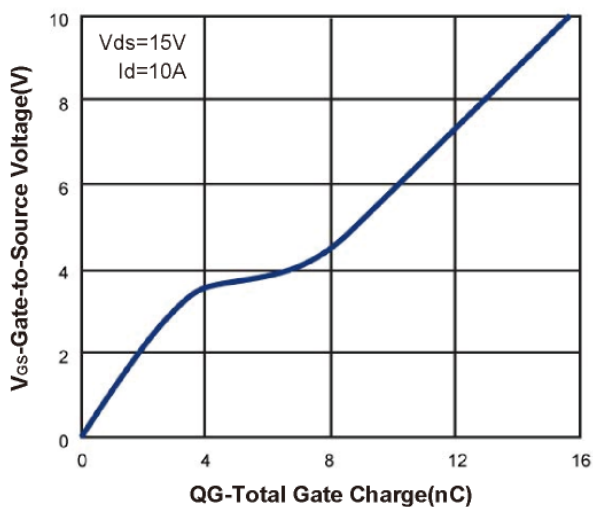
Typical Characteristics (T_J = 25°C Noted)



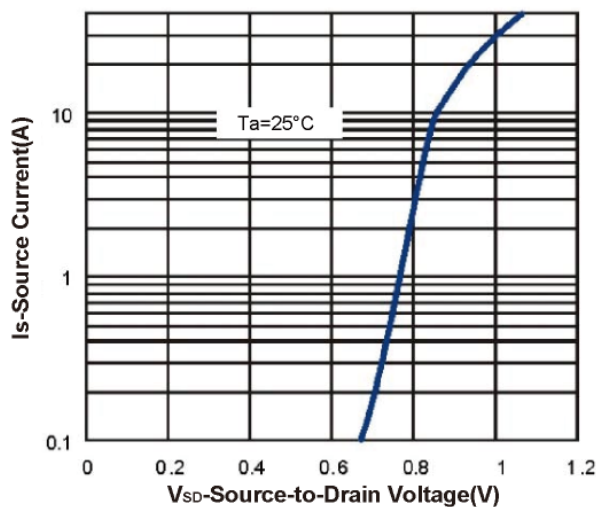
N-Channel 30V (D-S) MOSFET

Typical Characteristics (T_J = 25°C Noted)

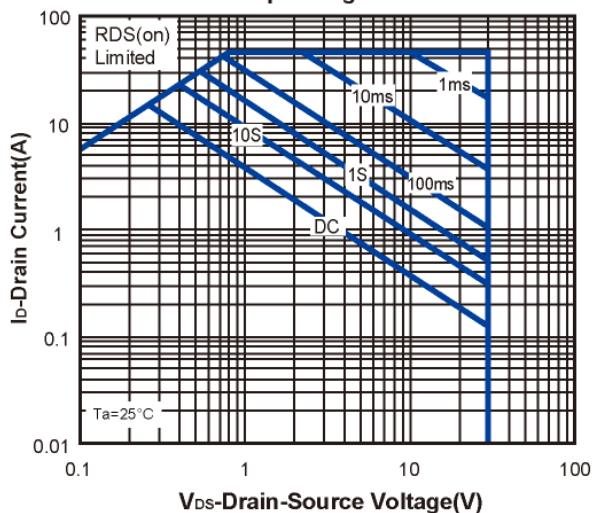
Gate Charge



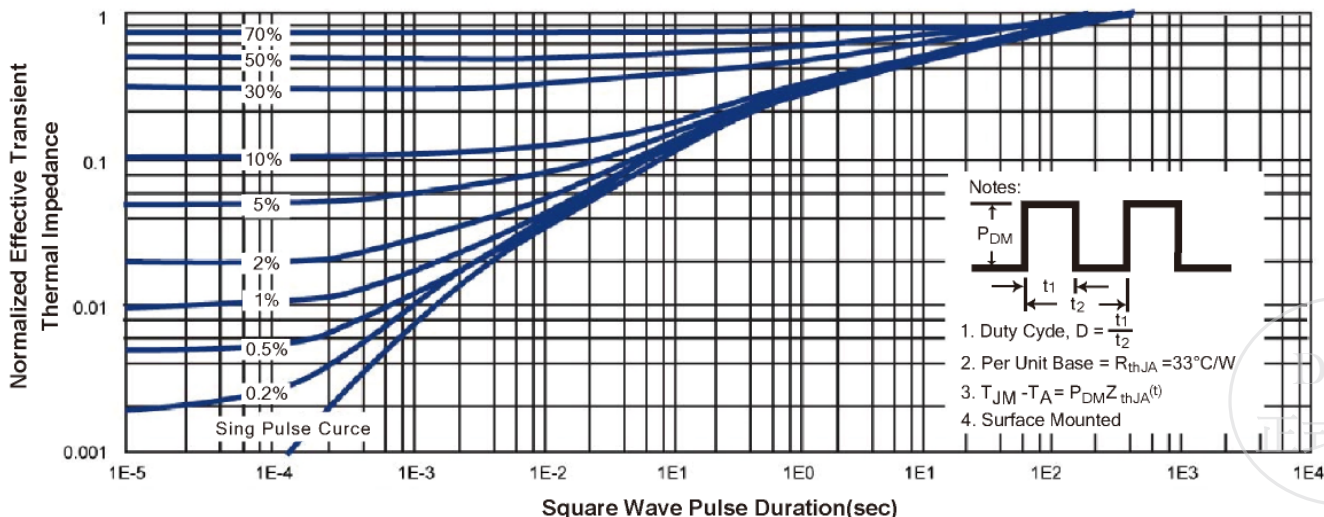
Body-diode characteristics



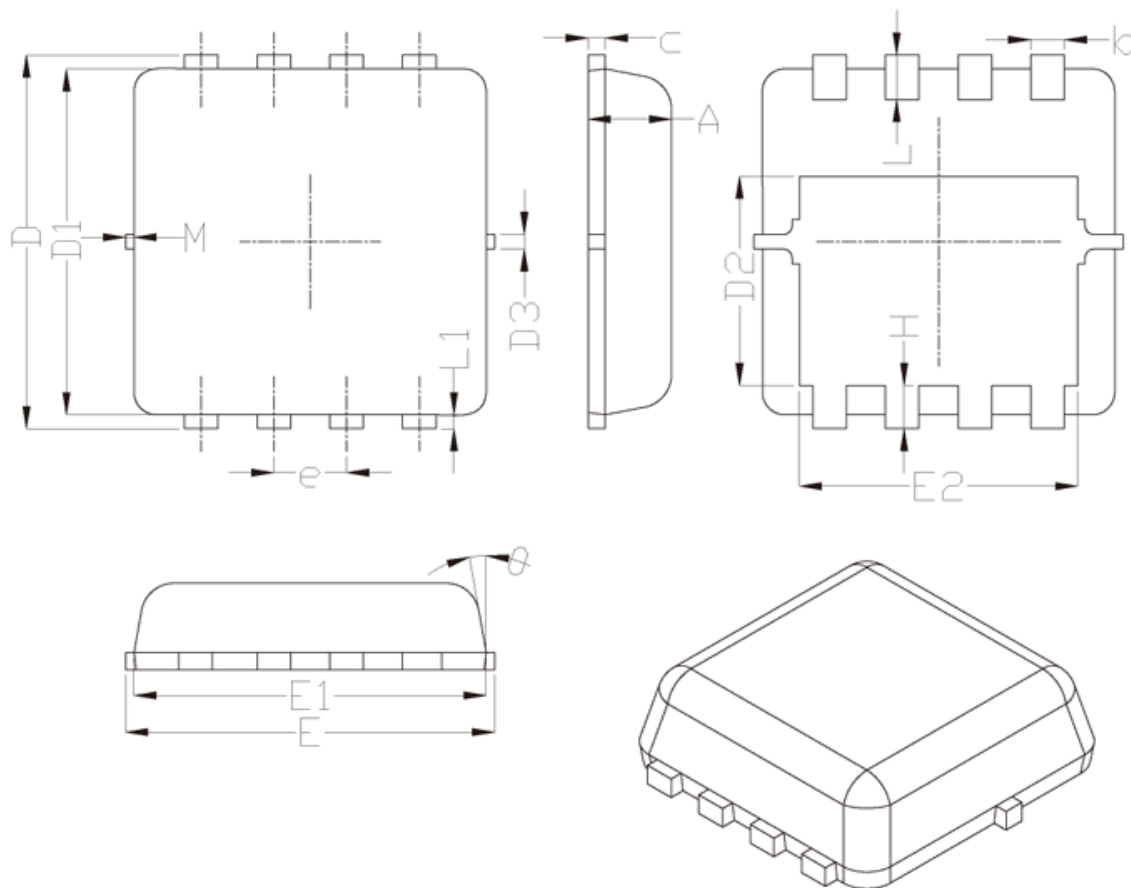
Maximum Forward Biased Safe Operating Area



Normalized Thermal Transient Impedance, Junction-to-Ambient



DFN(S) 3.3x3.3 Package Outline



SYMBOL	DIMENSIONAL REQMTS		
	MIN	NOM	MAX
A	0.70	0.75	0.80
b	0.25	0.30	0.35
c	0.10	0.15	0.25
D	3.25	3.35	3.45
D1	3.00	3.10	3.20
D2	1.78	1.88	1.98
D3	---	0.13	---
E	3.20	3.30	3.40
E1	3.00	3.15	3.20
E2	2.39	2.49	2.59
e	0.65BSC		
H	0.30	0.39	0.50
L	0.30	0.40	0.50
L1	---	0.13	---
θ	---	10°	12°
M	*	*	0.15

* Not specified

